

# IS1604

## OPIC Light Detector for 4 times Speed CD-ROM Drive

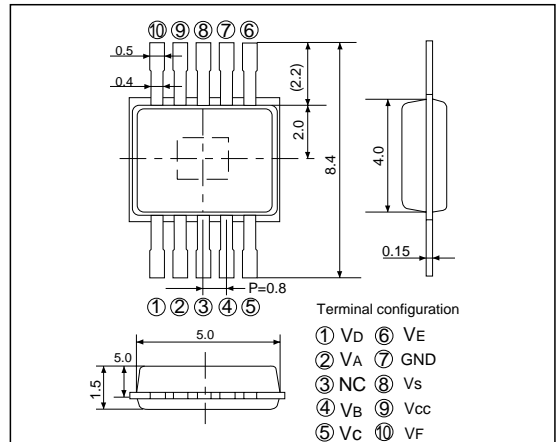
### ■ Features

- OPIC light detector for RF signal detection  
(6-division PIN and amplifier IC integrated onto single chip)
- High speed response type (response frequency : MIN. 8MHz)
- Compact and thin package  
(Package dimension : 5.0 x 4.0 x 1.5 mm)
- Customer-compatible light detector pattern

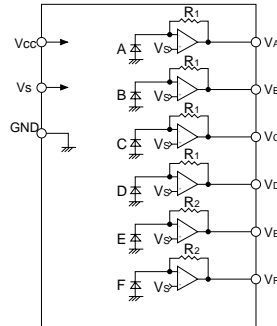
\*PINPD : PIN type photodiode

### ■ Outline Dimensions

(Unit : mm)

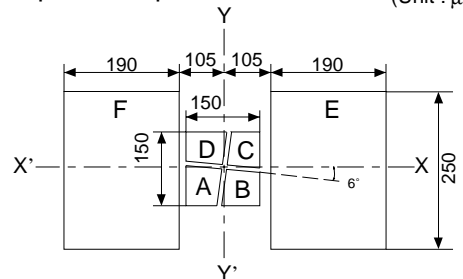


### Internal block diagram



### Shape of detector portion

(Unit :  $\mu\text{m}$ )



### ■ Applications

- CD-ROM drive (4 times speed)

### ■ Absolute Maximum Ratings

( $T_a=25^\circ\text{C}$ )

Parameter	Symbol	Rating	Unit
Supply voltage	$V_{CC}$	9	V
*1 Output voltage	$V_O$	$V_{CC}$	$^\circ\text{C}$
Operating temperature	$T_{opr}$	- 20 to + 80	$^\circ\text{C}$
Storage temperature	$T_{stg}$	- 40 to + 85	$^\circ\text{C}$
*2 Soldering temperature	$T_{sol}$	260	$^\circ\text{C}$

\*1 To apply to individual terminals of  $V_A$  to  $V_F$ .

\*2 For MAX. 3 seconds at the position of 1.0 mm from the resin edge

\* OPIC (Optional IC) is a trademark of the SHARP Corporation.

An OPIC consists of a light-detecting element and signal-processing circuit integrated onto a single chip.

■ Recommended Operating Conditions

Parameter	Symbol	MIN.	TYP.	MAX.	Unit
Operating supply voltage range 1	V <sub>cc</sub>	4.5	5	5.5	V
Operating supply voltage range 2	V <sub>s</sub>	V <sub>cc</sub> /2	V <sub>cc</sub> /2	V <sub>cc</sub> /2	V
*3 Incident light quantity range 1	φ P1	-	6	10	μ W
*4 Incident light quantity range 2	φ P2	-	6	10	μ W

\*3 To apply to individual detectors of A,B, C and D.

\*4 To apply to individual detectors of E and F.

■ Electro-optical Characteristics

(T<sub>a</sub> = 25°C, V<sub>cc</sub> = 5V, V<sub>s</sub> = 2.5V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit	Application
Supply current	I <sub>cc</sub>	-	0.6	1.5	4	mA	V <sub>cc</sub>
Output offset voltage	V <sub>od</sub>	Specified in pressure difference from V <sub>s</sub>	-15	0	+15	mV	V <sub>AtO</sub> V <sub>F</sub>
Output offset voltage differenc	Δ V <sub>od</sub>	A - B	-15	0	+15	mV	V <sub>A</sub> , V <sub>B</sub>
		C - D	-15	0	+15		V <sub>C</sub> , V <sub>D</sub>
		(A + C) - (B + D)	-15	0	+15		V <sub>AtO</sub> V <sub>D</sub>
		E - F	-15	0	+15		V <sub>E</sub> , V <sub>F</sub>
*5 Sensitivity 1	R <sub>p1</sub>	-	18	33	53	mV/μ W	V <sub>AtO</sub> V <sub>D</sub>
*5 Sensitivity 2	R <sub>p2</sub>	-	32	58	93	mV/μ W	V <sub>E</sub> , V <sub>F</sub>
*5 Sensitivity ratio	R <sub>p2</sub> /R <sub>p1</sub>	-	1.6	1.9	2.2	-	V <sub>AtO</sub> V <sub>F</sub>
*5 Sensitivity temperature coefficient	R <sub>pt</sub>	T <sub>a</sub> = -20 to +80°C	-	4 000	-	ppm/°C	V <sub>AtO</sub> V <sub>F</sub>
Response frequency 1	f <sub>c1</sub>	-3dB, CL = 30pF	8	11	-	MHz	V <sub>AtO</sub> V <sub>D</sub>
Response frequency 2	f <sub>c2</sub>	-3dB, CL = 30pF	1	1.5	-	MHz	V <sub>E</sub> , V <sub>F</sub>
Output noise level	V <sub>n</sub>	f = 2.9MHz, BW = 10kHz	-	-76	-64	dBm	V <sub>AtO</sub> V <sub>F</sub>

\*5 5μ W DC light (λ = 780 nm laser diode) is radiated to vicinity of the center of each detector at 30μφ.

Assuming the then output voltage as V<sub>p</sub> and the dark output voltage as V<sub>od</sub>, sensitivity R<sub>p</sub> is defined according to the following formula.

$$R_p = (V_p - V_{od}) / 5 \text{ m W}$$

Fig. 1 Response Frequency vs. Supply voltage

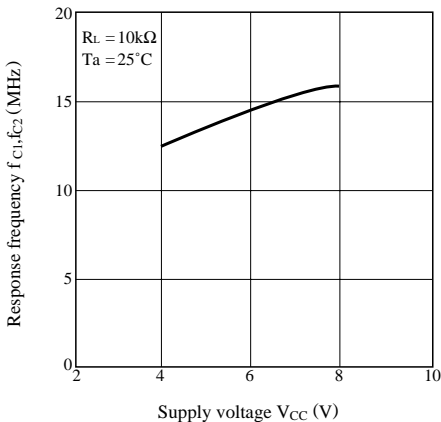
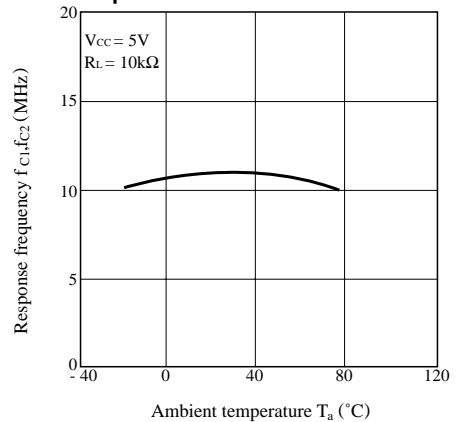


Fig. 2 Response Frequency vs. Ambient Temperature



● Please refer to the chapter "Precautions for Use". (Page 78 to 93)